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Kind regards,

Team Nexperia

BUK1M200-50SGTD

Quad channel logic level TOPFET Rev. 01 — 31 March 2003

Product data

Product profile

1.1 Description

Quad temperature and overload protected power switch based on TOPFET™ Trench technology in a 20-pin surface mount plastic package.

Product availability:

BUK1M200-50SGTD in SOT163-1 (SO20).

1.2 Features

- Power TrenchMOS™
- Overtemperature protection
- Overload protection
- Input-source voltage resets latched protection circuitry.
- Control of output stage and supply of Low operating input current permits overload protection circuits derived from input
- 5V logic compatible
- Current trip protection
- ESD protection for all pins
- Overvoltage clamping for turn off of inductive loads
 - direct drive by micro-controller.

1.3 Applications

- Low-side driver
- Pulse Width Modulation
- DC switching
- General purpose switch for driving lamps, motors, solenoids and heaters.

1.4 Quick reference data

Table 1: **Quick reference data**

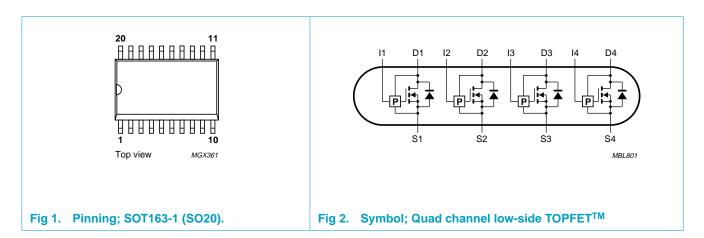
Symbol	Parameter		Min	Max	Unit
R _{DSon}	drain-source on-state resistance		-	200	m $Ω$
I _D	drain current		-	2.7	Α
P _{tot}	total power dissipation	[1]	-	9.4	W
Tj	junction temperature		-	150	°C
V _{DS}	drain-source voltage		-	50	V

^[1] All devices active.





2. Pinning information

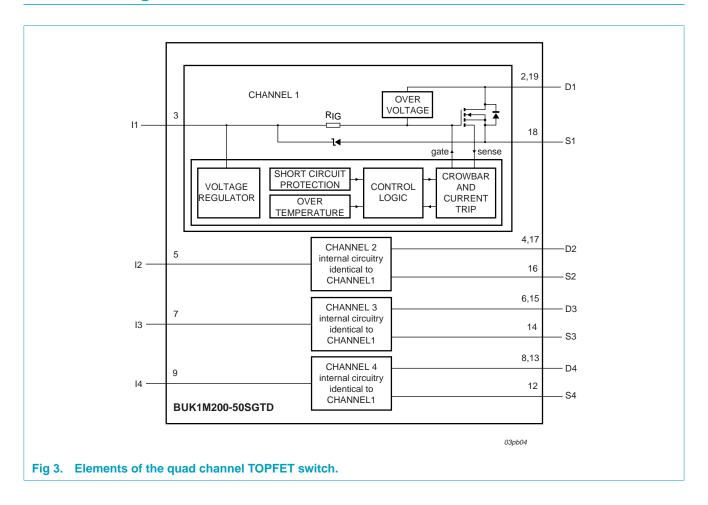


2.1 Pin description

Table 2: Pin description

Symbol	Pin	Description
n.c.	1, 11, 10, 20	not connected
D1	2,19	drain 1
I 1	3	input 1
D2	4,17	drain 2
12	5	input 2
D3	6,15	drain 3
13	7	input 3
D4	8, 13	drain 4
14	9	input 4
S4	12	source 4
S3	14	source 3
S2	16	source 2
S1	18	source 1

3. Block diagram



4. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage		[1]	-	50	V
I _D	drain current	T _{sp} = 25 °C; Figure 5	[2][3]	-	2.7	Α
I _I	input current	clamping		-	3	mΑ
I _{IMS}	non-repetitive peak input current	t _p ≤ 1 ms		-	10	mΑ
P _{tot}	total power dissipation	T _{sp} = 25 °C; Figure 4	[4]	-	9.4	W
T _{stg}	storage temperature			-55	+150	°C
Tj	junction temperature	normal operation	[5]	-	150	°C
Overvolta	ige clamping ^[6]					
E _{DS(CL)S}	non-repetitive drain-source clamping energy	T_{amb} = 25 °C; $I_{DM} \le I_{D(th)(trip)}$; inductive load	[3]	-	100	mJ
E _{DS(CL)R}	repetitive drain-source clamping energy	$T_{sp} \le 125~^{\circ}C;~I_{DM} = 1~A;~f = 250~Hz$	[3]	-	5	mJ
Overload	protection [7]					
V _{DS(prot)}	protected drain-source voltage	$V_{IS} \ge 4 V$		-	35	V
Reverse o	diode					
I _S	source (diode forward) current	$T_{sp} \le 25 ^{\circ}C; V_{IS} = 0 V$		-	2	Α
Electrosta	atic discharge					
V _{esd}	electrostatic discharge voltage	$C = 250 \text{ pF}; R = 1.5 \text{ k}\Omega$		-	2	kV

^[1] Prior to the onset of overvoltage clamping. For voltages above this value, safe operation is limited by the overvoltage clamping energy.

^[2] Refer to overload protection characteristics.in Table 5.

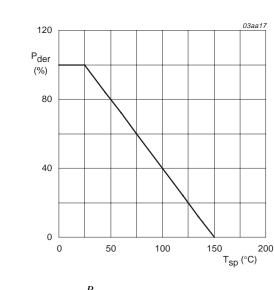
^[3] For a single active device.

^[4] For all devices active.

^[5] Not in an overload condition with drain current limiting.

^[6] At a drain-source voltage above 50 V the power MOSFET is actively turned on to clamp overvoltage transients.

^[7] With the protection supply provided via the input pin, the TOPFET is protected from short circuit loads. Overload protection operates by means of drain current trip or by activating the overtemperature protection.



 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$

Fig 4. Normalized total power dissipation as a function of solder point temperature.

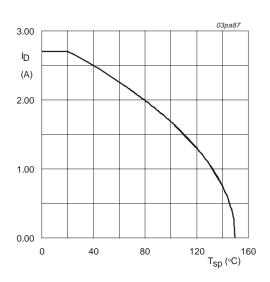


Fig 5. Continuous drain current as a function of solder point temperature.

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to	mounted on thermo clad board				
	solder point.	one device active	-	-	45	K/W
		all devices active	-	-	13.3	K/W

6. Static characteristics

Table 5: Static characteristics

Limits are valid for $-40\,^{\circ}C \le T_{sp} \le +150\,^{\circ}C$ and typical values for $T_{sp} = 25\,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Off-state	output characteristics						
V _{DS(CL)}	drain-source clamping voltage	$V_{IS} = 0 \text{ V}; I_D = 10 \text{ mA}$		50	-	-	V
		$\begin{aligned} &V_{\text{IS}} = 0 \text{ V; } I_{\text{D}} = 200 \text{ mA; } t_{\text{p}} \leq 300 \mu\text{s;} \\ &\delta \leq 0.01; \text{ Figure 18} \end{aligned}$		50	62	70	V
I _{DSS}	drain-source leakage current	$V_{IS} = 0 \ V; \ V_{DS} = 40 \ V$		-	-	100	μΑ
		T _{sp} = 25 °C; Figure 19		-	0.05	10	μΑ
On-state	output characteristic						
R_{DSon}	drain-source on-state resistance	$\begin{split} V_{IS} \geq 4 \ V; \ t_p \leq 300 \ \mu s; \ \delta \leq 0.01; \\ I_D = 100 \ mA \end{split}$		-	-	380	mΩ
		T _{sp} = 25 °C; Figure 8 and 9		-	150	200	mΩ
Input cha	racteristics [1]						
$V_{IS(th)}$	input-source threshold voltage	$V_{DS} = 5 \text{ V}; I_{D} = 1 \text{ mA}$		0.6	-	2.4	V
		T _{sp} = 25 °C; Figure 13		1.1	1.6	2.1	V
I _{IS}	input supply current	normal operation					
		V _{IS} = 5 V		100	220	400	μΑ
		$V_{IS} = 4 V$		80	195	330	μΑ
		protection latched					
		$V_{IS} = 5 V$		1.4	2	2.5	mA
		V _{IS} = 3 V; Figure 14 and 16		0.7	1.1	1.5	mA
V _{IS(rst)}	input-source reset voltage	t _{rst} ≥ 100 μs; Figure 17	[2]	1.5	2	2.5	V
t _{rst(latch)}	latch reset time		[3]	10	40	100	μs
V _{IS(CL)}	input-source clamping voltage	I _I = 1.5 mA; Figure 15		5.5	-	8.5	V
R _{IG}	input-gate resistance		[4]	-	2.5	-	kΩ
Overload	protection characteristic [5]						
I _{D(th)(trip)}	drain current trip threshold	$4 \text{ V} \leq \text{V}_{\text{IS}} \leq 5.5 \text{ V}$					
		T _{sp} = 25 C; Figure 11		4	6.1	8	Α
		Figure 10		3	6.1	9	Α
Overtem	perature protection characteristic						
T _{j(th)}	threshold junction temperature	4 V ≤ V _{IS} ≤ 5.5 V; Figure 12		150	170	-	°C
Source d	rain diode characteristic						
V_{SD}	source-drain (diode forward) voltage	$I_S = 2 \text{ A}; \ V_{IS} = 0 \text{ V}; \ t_p = 300 \ \mu \text{s}$		-	0.83	1.1	V

^[1] The supply for the logic and overload protection is taken from the input.

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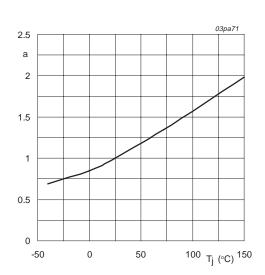
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^[2] The input voltage below which the overload protection circuits will be reset.

^[3] To reset the protection circuitry from the latched state, V_{IS} is reduced from 5 V to 1 V.

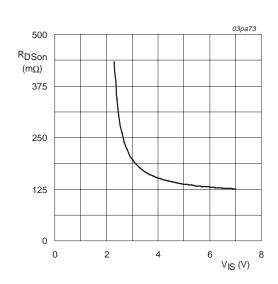
^[4] Not directly measurable from device terminals.

^[5] The TOPFET switches off to protect itself when one of the overload thresholds is exceeded. It remains latched off until reset by the input.



$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 6. Normalized drain-source on-state resistance factor as a function of junction temperature.



$$T_j$$
 = 25 °C; I_D = 100 mA; t_p = 300 μs

Fig 7. Drain-source on-state resistance as a function of input-source voltage; typical values.

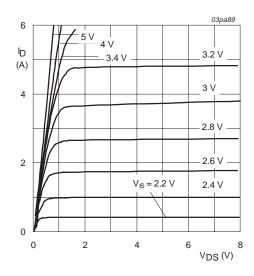


Fig 8. Output characteristics; drain current as a function of drain-source voltage; typical values.

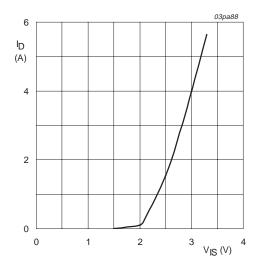
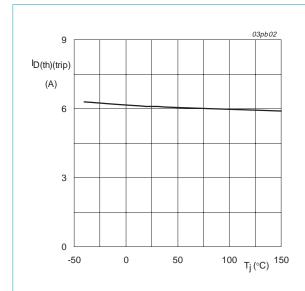


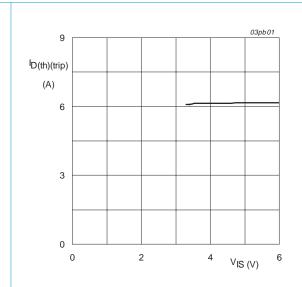
Fig 9. Transfer characteristics; drain current as a function of input-source voltage; typical values.

Product data



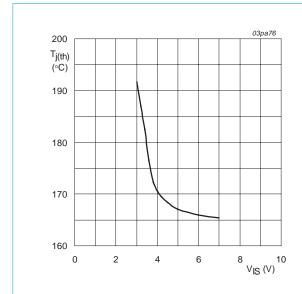
 $T_i = 25 \, ^{\circ}C; t_p = 300 \, \mu s$

Fig 10. Drain current trip threshold as a function of junction temperature; typical values.



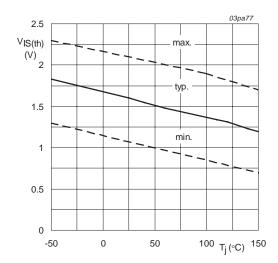
 T_{j} = 25 °C; V_{DS} = 10 V; t_{p} = 300 μs

Fig 11. Drain current trip threshold as a function of input-source voltage; typical values.



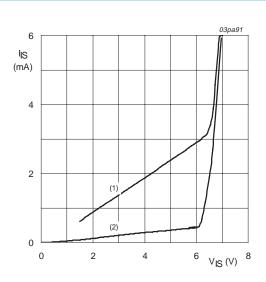
 $V_{DS} = 5 \text{ V}; V_{IS} = 5 \text{ V}; t_p = 300 \text{ }\mu\text{s}$

Fig 12. Overtemperature protection characteristic; threshold junction temperature as a function of input-source voltage; typical values.



 $T_j = 25 \, ^{\circ}\text{C}; \, V_{DS} = 5 \, \text{V}; \, t_p = 300 \, \mu\text{s}$

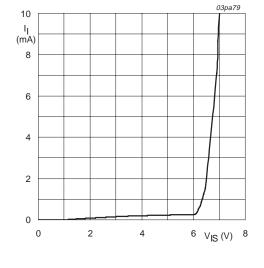
Fig 13. Input-source threshold voltage as a function of junction temperature.



T_i = 25 °C

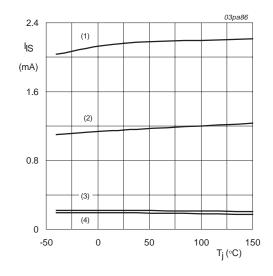
- (1) Input-source current; protection latched.
- (2) Input-source current; normal operation.

Fig 14. Input-source current as a function of input-source voltage; typical values.



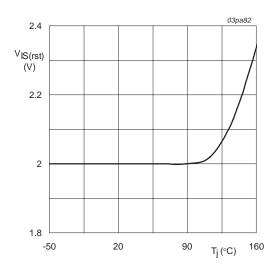
T_j = 25 °C

Fig 15. Input clamping characteristic; input current as a function of input-source voltage; typical values.



- (1) $V_{IS} = 5 V$; protection latched
- (2) $V_{IS} = 3 V$; protection latched
- (3) $V_{IS} = 5 \text{ V}$; normal operation
- (4) $V_{IS} = 4 V$; normal operation

Fig 16. Input-source current as a function of junction temperature; typical values.



 $t_r = 100 \ \mu s$

Fig 17. Input-source reset voltage as a function of junction temperature; typical values.

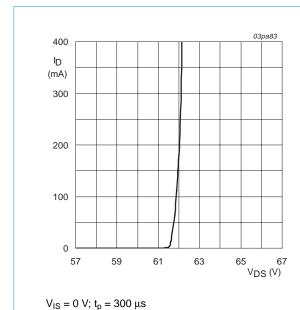
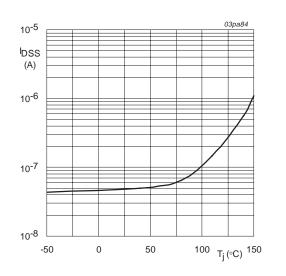


Fig 18. Overvoltage clamping characteristic; drain current as a function of drain-source voltage; typical values.



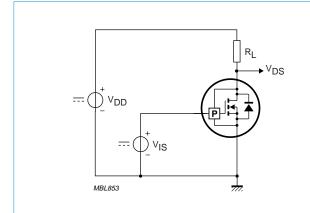
 $V_{DS} = 40 \text{ V}; V_{IS} = 0 \text{ V}$

Fig 19. Drain-source leakage current as a function of junction temperature; typical values.

7. Dynamic characteristics

Table 6: Switching characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Switchin	g					
t _{d(on)}	turn-on delay time	R_L = 50 Ω ; I_D = 250 mA; V_{IS} = 5 V ;	-	0.5	0.9	μs
t _r	rise time	T _{sp} = 25 °C; Figure 20 and 21	-	0.7	1.5	μs
$t_{d(off)}$	turn-off delay time		-	3.2	6.5	μs
t _f	fall time		-	1.6	3.5	μs





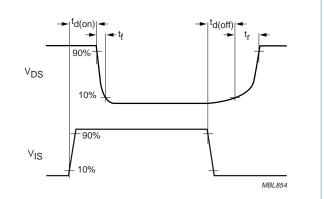
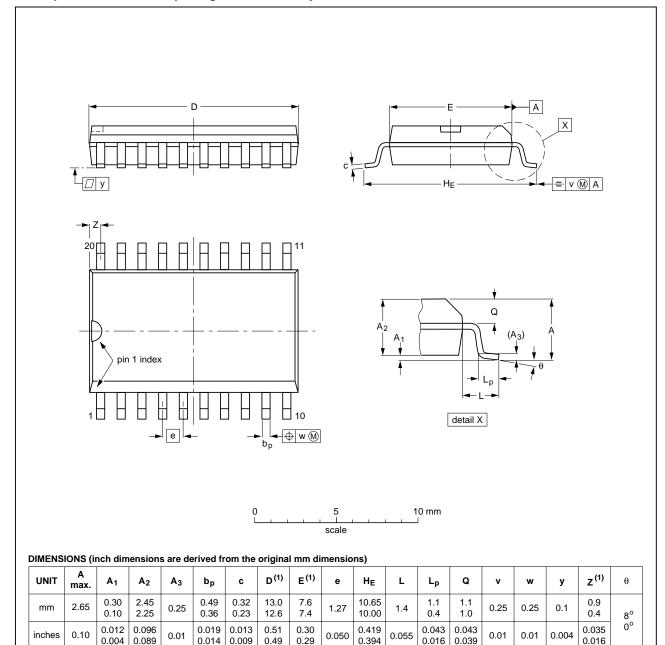


Fig 21. Resistive load switching waveforms.

8. Package outline

SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ICCUIT DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT163-1	075E04	MS-013			97-05-22 99-12-27	

Fig 22.

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9. Revision history

Table 7: Revision history

Rev	Date	CPCN	Description
01	20030331	-	Product data (9397 750 10955)

10. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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- For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

11. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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Philips Semiconductors

BUK1M200-50SGTD

Quad channel logic level TOPFET

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